

<b>Notice of References Cited</b>	Application/Control No. 09/828,227	Applicant(s)/Patent Under Reexamination SHIMAZAKI, MUTSUMI	
	Examiner Russell Frejd	Art Unit 2128	Page 1 of 1

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	X	PIEPER et al., R. Personal Computer Assisted Tutorial for Smith Charts, IEEE, Proceedings of the 33rd Southeastern Symposium on System Theory, March 2001, pages 139-143.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.